

**Notice of References Cited**Application/Control No.  
10/008,646Applicant(s)/Patent Under  
Reexamination  
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1773

Page 1 of 1

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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.